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Physica E ■■■ (■■■■) ■■■-■■■

PHYSICA E

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Tuned exciton kinetics in self-organized InGaAs/GaAs quantum dots

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Abstract

The exciton dynamics in self-organized InGaAs/GaAs quantum dots with systematically varying structural properties is investigated by time-resolved photoluminescence spectroscopy. Decreasing the lateral confinement by ex situ annealing increases the exciton lifetime and accelerates intradot relaxation. The altered exciton dynamics is attributed to the decreasing electron-hole overlap in the annealed QDs, resulting from the smoother confinement potential. The results demonstrate the effect of the actual confinement potential on the exciton-photon and exciton-phonon interactions, pointing out possible pathways to device optimization. © 2002 Published by Elsevier Science B.V.

PACS: 78.47+p; 78.67.Hc; 78.55.Cr

Keywords: Exciton; Quantum dot; Time-resolved photoluminescence

Within the last decade quantum dots (QDs) attracted continuously increasing interest due to their unique optical properties. The coherent nature of defect-free self-organized QDs suppresses the interaction with surface and defect states, which often mask the intrinsic properties [1]. This is particularly crucial for the investigation of the carrier/exciton dynamics. The oscillator strength of excitons in QDs is predicted to show a characteristic size dependence, scaling with the localization (i.e. the QD) volume and saturating for small QDs [2]. Nevertheless, realistic calculations based on pseudo-potential [3] and 8 band kp [4] theory revealed a strong shape dependence. Additionally, the composition of the QD is attributed to alter the excitonic carrier wavefunctions in small QDs. Thus, annealing induced systematic changes of

of the confinement potential reveal new insights into the exciton dynamics in zero-dimensional structures. 33

Self-organized QDs formed in the In(Ga)As/GaAs system provide strong quantum confinement, i.e. the size of the QDs (typically 20 nm width by 3–10 nm height) is sufficiently small for confinement energies to exceed Coulomb energies. For such QD structures a variety of time-resolved photoluminescence (TRPL) measurements are reported [5,6]. The observed spread of the decay time ranging from some hundred picosecond up to several nanosecond is not understood yet. Up to now, quantitative descriptions of the dynamics are limited to idealized dots, assuming a complete overlap of the electron and hole wave functions within the structure [2]. The exciton lifetime is expected to scale reciprocal to the QD volume $V/(\pi a_B^3)$ [7]. Thereby, the effect of inequivalent electron and hole wavefunctions in low-symmetry strained QDs and, thus, the actual structural properties have been neglected. 35 37 39 41 43 45 47 49 51

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1 In this paper, we present resonantly excited TRPL
 2 experiments on a series of annealed self-organized
 3 InGaAs/GaAs QDs with systematically chang-
 4 ing structural properties. The investigated sam-
 5 ples were derived from a single sample by ex
 6 situ annealing as described in detail in Ref. [8].
 7 The original ('as-grown') dots were fabricated by
 8 MOCVD on a GaAs (001) substrate depositing
 9 five monolayers of $\text{In}_{0.5}\text{Ga}_{0.5}\text{As}$ and capping them
 10 with GaAs at 485°C . Transmission electron mi-
 11 croscope images revealed $\sim 10^9$ QDs/cm² with a
 12 flat, truncated shape. Different pieces of the sam-
 13 ple were annealed at 580°C , 610°C , 640°C , and
 14 700°C . The sharp potential steps, especially in
 15 the growth direction, are smoothed by the ther-
 16 mal treatment and the localization decreases for
 17 both electrons and holes. The averaged Ga con-
 18 tent of the QDs increases leading to an increas-
 19 ing ground state transition energy [8,9]. Simul-
 20 taneously the effective QD size increases [10].
 21 With decreasing localization an increasing influ-
 22 ence of the respective effective carrier mass
 23 is expected, leading to a decreasing overlap of
 24 the electron and hole wavefunctions, with an
 25 extension reciprocal on the respective effective
 26 mass.

27 Photoluminescence (PL) spectra (Fig. 1) excited by
 28 an cw Ar^+ -laser at 2.4 eV with an excitation density
 29 of $\sim 5 \text{ kW/cm}^2$ reveal ground (I0) and excited state
 30 transitions (I1, I2). The transitions exhibit a blueshift
 31 with annealing, which is attributed to the increasing
 32 Ga content inside the QDs. Simultaneously, the energy
 33 spacing of adjacent transitions decreases mirroring the
 34 decreasing quantization due to the increasing effective
 35 QD size.

36 The downwards pointing arrows in Fig. 1 denote
 37 the excitation energies used for the TRPL measure-
 38 ments whereas the upwards pointing arrows mark the
 39 corresponding detection energies. Fig. 2 shows typi-
 40 cal transients excited resonantly to I1 and recorded at
 41 the denoted transitions. The dots represent the mea-
 42 surements while the solid lines are fits using an ex-
 43 ponential rise and decay, respectively, folded with the
 44 system response (dubbed laser). The investigated flat
 45 QDs exhibit a fairly fast (~ 350 ps) recombination of
 46 the ground and first excited state transition. Addition-
 47 ally, the decay of the first excited state transition is
 mirrored by the rise of the ground state transition. The

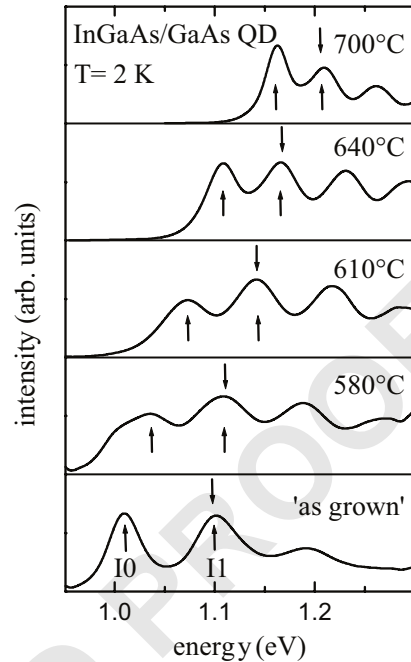


Fig. 1. High excitation density PL spectra of the annealed quantum dot samples. The ground (I0) and first excited (I1) state transitions are indicated by upward arrows, denoting the detection energies for the TRPL measurements, while downward arrows mark the respective excitation energies.

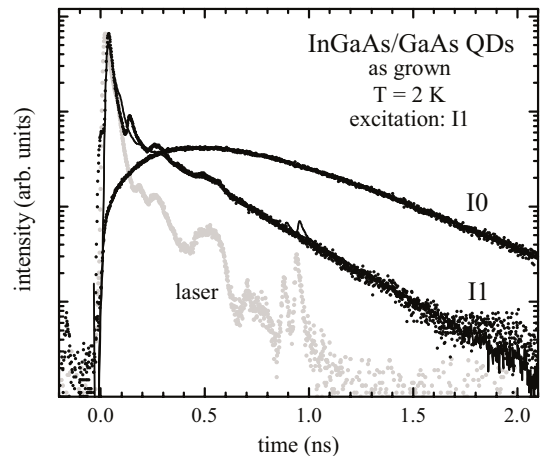


Fig. 2. TRPL transients of I0 and I1 for the 'as grown' sample excited resonantly to the first excited state transition I1. Dots represent the measured transients while solid lines denote fits.

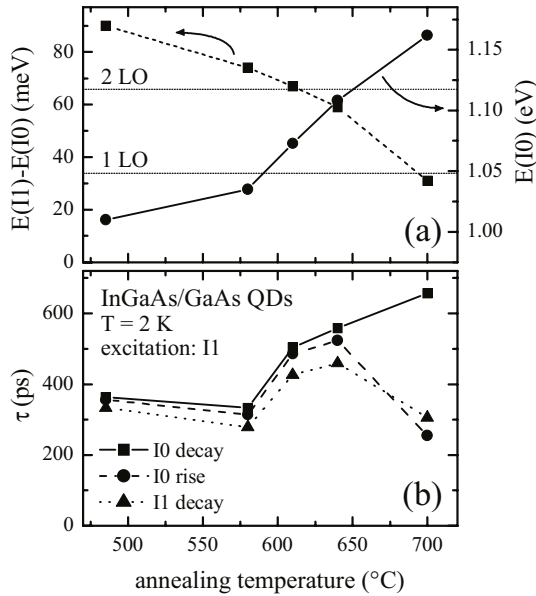


Fig. 3. The annealing-induced structural changes lead to an increase of the ground state transition energy while the substate splitting decreases (panel (a)). The lines 1LO and 2LO correspond to the energy of 1 and 2 phonons compared to the substate splitting (left scale). Contrary to a predicted decrease of the lifetime (increasing QD size) the heat treatment induced In/Ga interdiffusion leads to an increase of the lifetime by a factor of 2.

1 slow rise time of I0 indicates a suppressed relaxation
 2 due to a negligible phonon coupling as reported recently [6].
 3

4 The time constants shown in Fig. 3(b) were derived from transients excited resonantly in I1 while
 5 detecting at I0 and I1, respectively, whereas the corresponding ground state transition energy and substate
 6 splitting are depicted in Fig. 3(a). Obviously, the exciton dynamics is dominated by the actual confining
 7 potential. The lifetime of I0 increases in the annealed samples. That of I1 behaves similar up to 640°C.
 8 At higher annealing temperatures the decay of I1 accelerates becoming finally twice as fast as that of I0.
 9 Interestingly, the radiative lifetime increases with increasing effective QD size, whereas commonly the opposite
 10 trend is expected [2]. Furthermore, we find the rise of I0 to mirror decay of I1 in all samples indicating
 11 an excitonic relaxation [6].
 12

13 The bright exciton lifetime in the strong confinement limit is proportional to $1/(EP_{cv}^2I)$ [5] where
 14 E is the transition energy, P_{cv} the optical inter-
 15

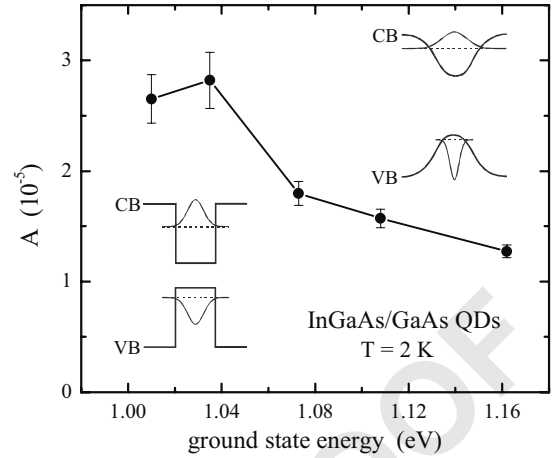


Fig. 4. Dimensionless quantity A , proportional to the oscillator strength, derived from the measured ground state lifetime. The insets indicate qualitatively the decreasing overlap of electron and hole wavefunctions caused by the annealing-induced smoothing of the confinement potential.

band matrix element representing the contribution
 of the Bloch-functions and I the overlap integral of
 electron and hole envelope functions. As shown in
 Fig. 4 the product $A \sim (P_{cv}^2 I)$, being proportional
 to the oscillator strength, decreases significantly
 upon annealing. Due to the small influence of P_{cv}
 (for $\text{In}_x\text{Ga}_{1-x}\text{As}$ P_{cv} is expected to vary by only
 10%) the major effect can be attributed to a
 decreasing electron–hole overlap. The overlap of
 excitonic electron and hole wavefunctions is sensitive
 to the actual confining potential [4,5]. Changes in
 shape and composition induced, for instance, by
 annealing allow to tune the overlap of the wave-
 functions and, thus, the oscillator strength of strongly
 confined excitons in self-organized QDs. In conse-
 quence an effective pathway for tuning the dynam-
 ics in self-organized QDs is provided by optimizing
 the confining potential.

In conclusion, a significant influence of the
 electron–hole overlap integral on the exciton dynam-
 ics in self-organized InGaAs/GaAs QDs was
 demonstrated. Ex situ annealing slows down radiative
 recombination and accelerates relaxation in qualita-
 tive agreement with the expected change of the
 electron–hole overlap caused by In/Ga interdiffusion.
 The results unambiguously evidence the effect of the
 complex confining potential of strained self-organized

1 QDs on the exciton dynamics, pointing out possible
 3 pathways to optimize such QDs for device applica-
 tions.

5 This work was supported by the Deutsche Fors-
 chungsgemeinschaft in the framework of
 Sonderforschungsbereich 296.

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